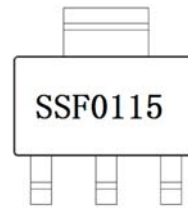
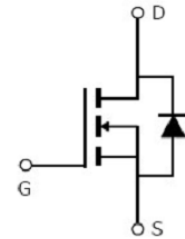


**Main Product Characteristics:**

$V_{DSS}$	100V
$R_{DS(on)}$	90m $\Omega$ (typ.)
$I_D$	6.5A ①


**SOT223**

**Marking and pin Assignment**

**Schematic diagram**
**Features and Benefits:**

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 175°C operating temperature


**Description:**

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

**Absolute max Rating:**

Symbol	Parameter	Max.	Units
$I_D @ TC = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ ①	6.5	A
$I_D @ TC = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ ①	4.2	
$I_{DM}$	Pulsed Drain Current ②	26	
$P_D @ TC = 25^\circ C$	Power Dissipation ③	7.6	W
	Linear Derating Factor	0.019	W/°C
$V_{DS}$	Drain-Source Voltage	100	V
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy @ L=30mH	79	mJ
$I_{AS}$	Avalanche Current @ L=30mH	2.3	A
$T_J T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +175	°C

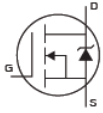
## Thermal Resistance

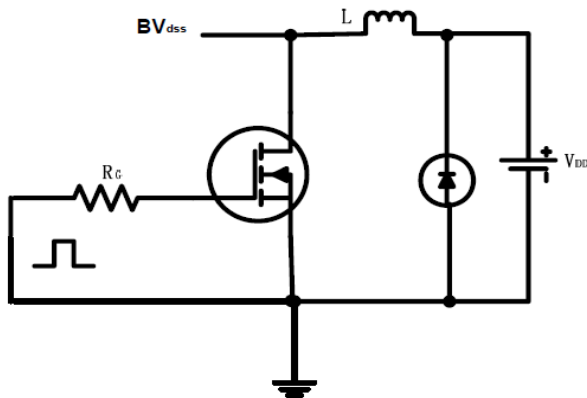
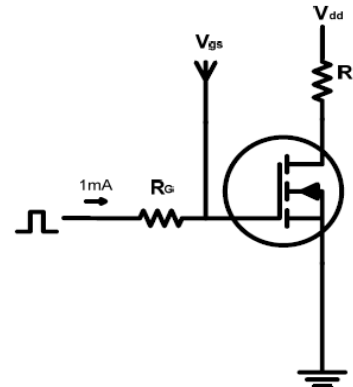
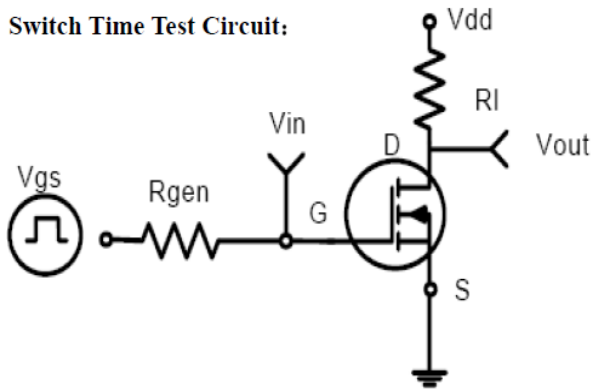
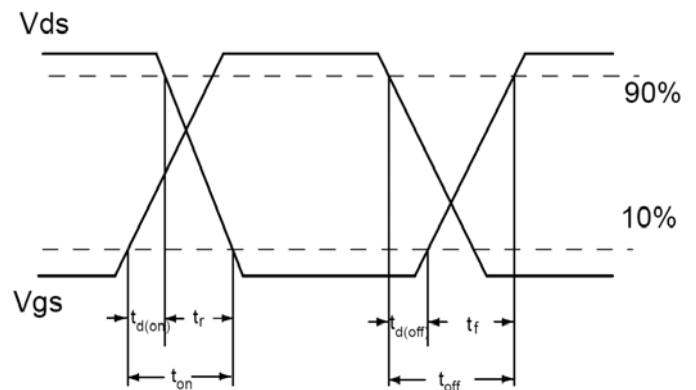
Symbol	Characterizes	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-case ③	—	20	°C/W
R <sub>θJA</sub>	Junction-to-Ambient (t ≤ 10s) ④	—	69	°C/W

## Electrical Characterizes @T<sub>A</sub>=25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source breakdown voltage	100	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
R <sub>DS(on)</sub>	Static Drain-to-Source on-resistance	—	90	150	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> = 2A T <sub>J</sub> = 125°C
		—	150	—		
V <sub>GS(th)</sub>	Gate threshold voltage	2	—	4	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA T <sub>J</sub> = 125°C
		—	2.46	—		
I <sub>DSS</sub>	Drain-to-Source leakage current	—	—	1	μA	V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V T <sub>J</sub> = 125°C
		—	—	50		
I <sub>GSS</sub>	Gate-to-Source forward leakage	—	—	100	A	V <sub>GS</sub> = 20V
	Gate-to-Source reverse leakage	—	—	-100		V <sub>GS</sub> = -20V
Q <sub>g</sub>	Total gate charge	—	30	—	nC	I <sub>D</sub> = 9.2A
Q <sub>gs</sub>	Gate-to-Source charge	—	4.3	—		V <sub>DD</sub> =80V
Q <sub>gd</sub>	Gate-to-Drain("Miller") charge	—	7.6	—		V <sub>GS</sub> = 10V
t <sub>d(on)</sub>	Turn-on delay time	—	11	—	ns	V <sub>GS</sub> =10V, V <sub>DD</sub> =50V, R <sub>L</sub> =5.4Ω, R <sub>GEN</sub> =18Ω I <sub>D</sub> = 9.2A
t <sub>r</sub>	Rise time	—	31	—		
t <sub>d(off)</sub>	Turn-Off delay time	—	39	—		
t <sub>f</sub>	Fall time	—	28	—		
C <sub>iss</sub>	Input capacitance	—	739	—	pF	V <sub>GS</sub> = 0V V <sub>DS</sub> = 25V f = 1MHz
C <sub>oss</sub>	Output capacitance	—	58	—		
C <sub>rss</sub>	Reverse transfer capacitance	—	40	—		

## Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	6.5 ①	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I <sub>SM</sub>	Pulsed Source Current (Body Diode)	—	—	26	A	
V <sub>SD</sub>	Diode Forward Voltage	—	0.8	1.3	V	I <sub>S</sub> =3A, V <sub>GS</sub> =0V, T <sub>J</sub> = 25°C
t <sub>rr</sub>	Reverse Recovery Time	—	30	—	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 4.2A,
Q <sub>rr</sub>	Reverse Recovery Charge	—	55	—	nC	di/dt = 100A/μs

**Test circuits and Waveforms**
**EAS test circuits:**

**Gate charge test circuit:**

**Switch Time Test Circuit:**

**Switch Waveforms:**

**Notes:**

- ① Calculated continuous current based on maximum allowable junction temperature.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- ④ The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$

Typical electrical and thermal characteristics

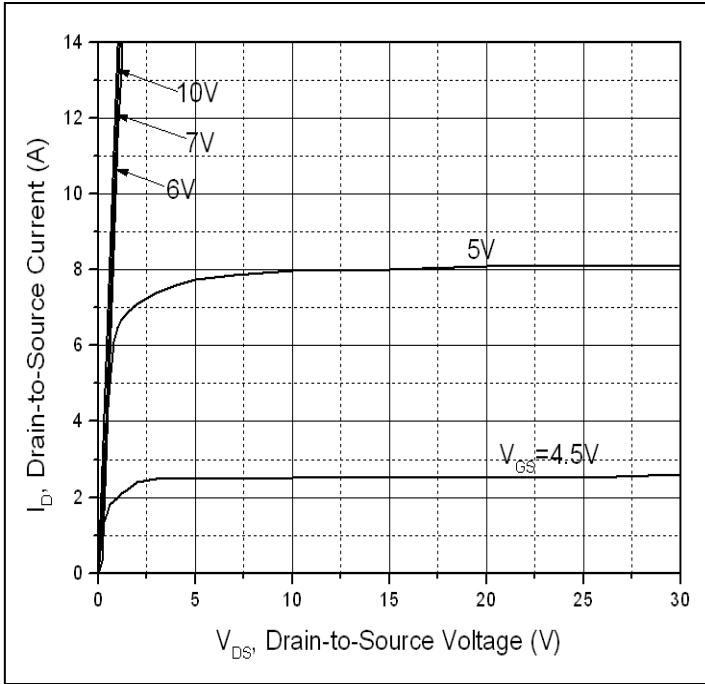


Figure 1: Typical Output Characteristics

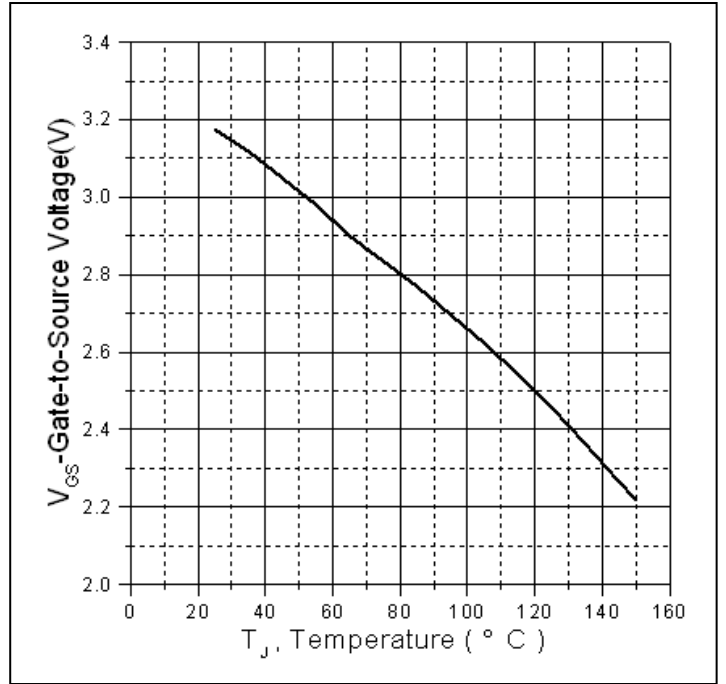


Figure 2: Gate to source cut-off voltage

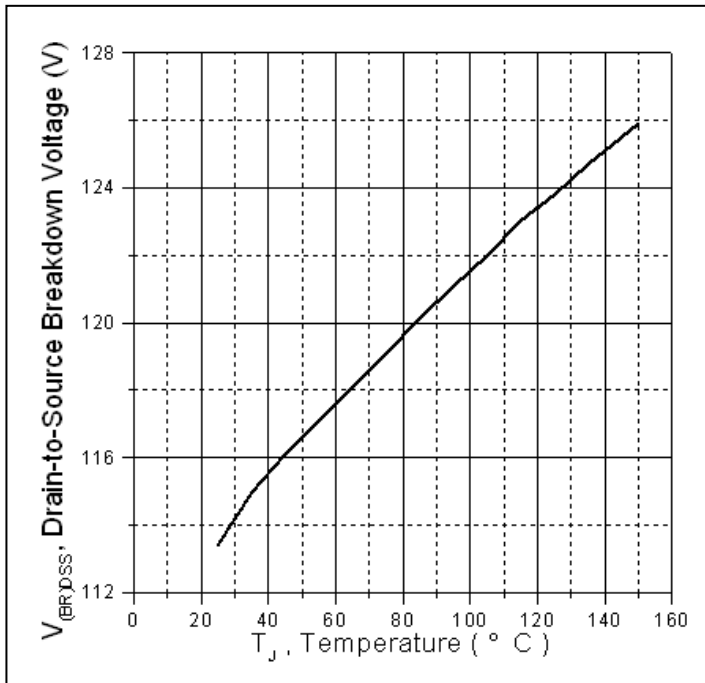


Figure 3: Drain-to-Source Breakdown Voltage vs. Case Temperature

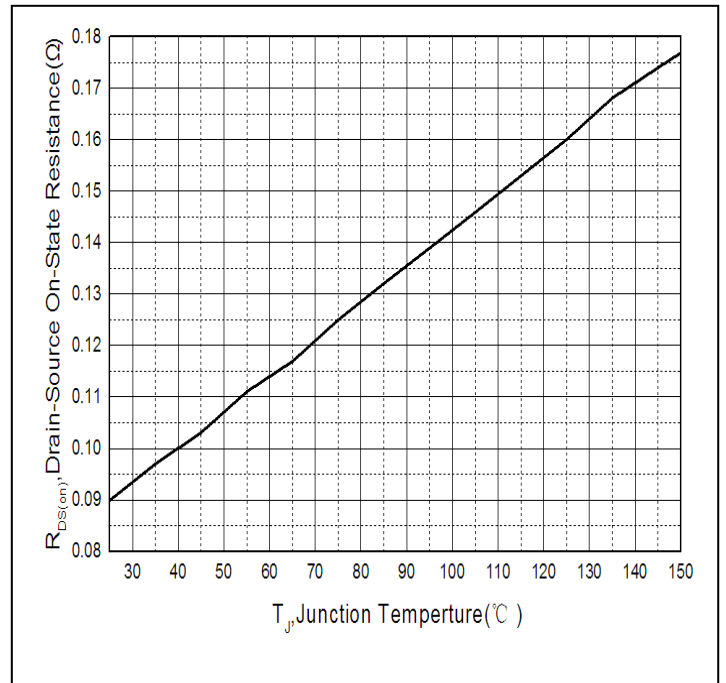


Figure 4: Normalized On-Resistance vs. Case Temperature

Typical electrical and thermal characteristics

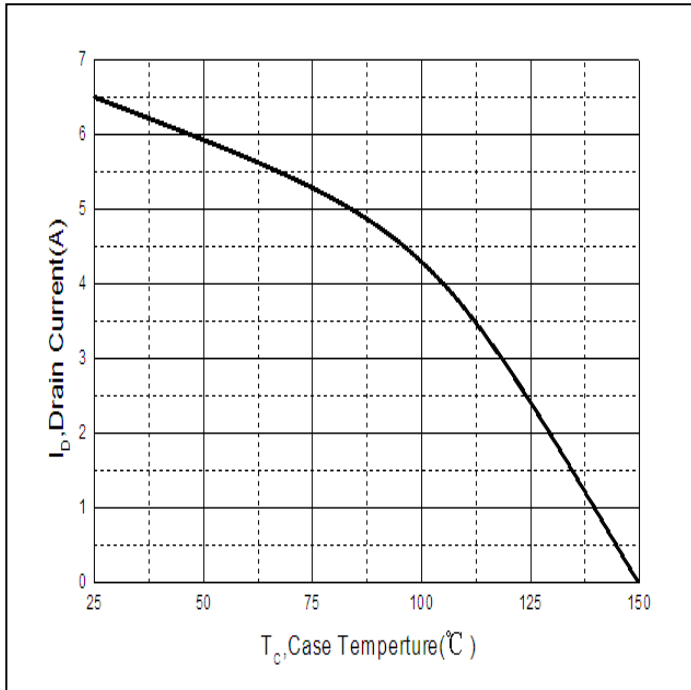


Figure 5: Maximum Drain Current vs. Case Temperature

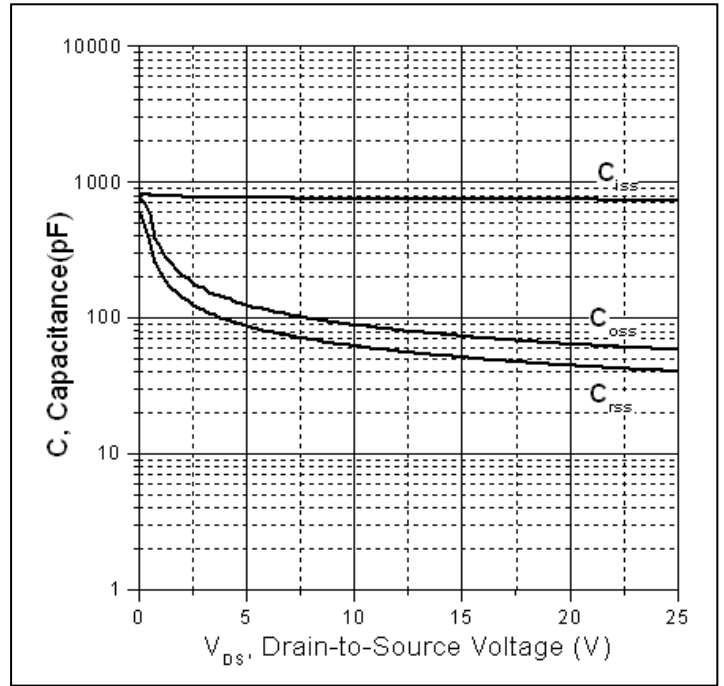


Figure 6: Typical Capacitance vs. Drain-to-Source Voltage

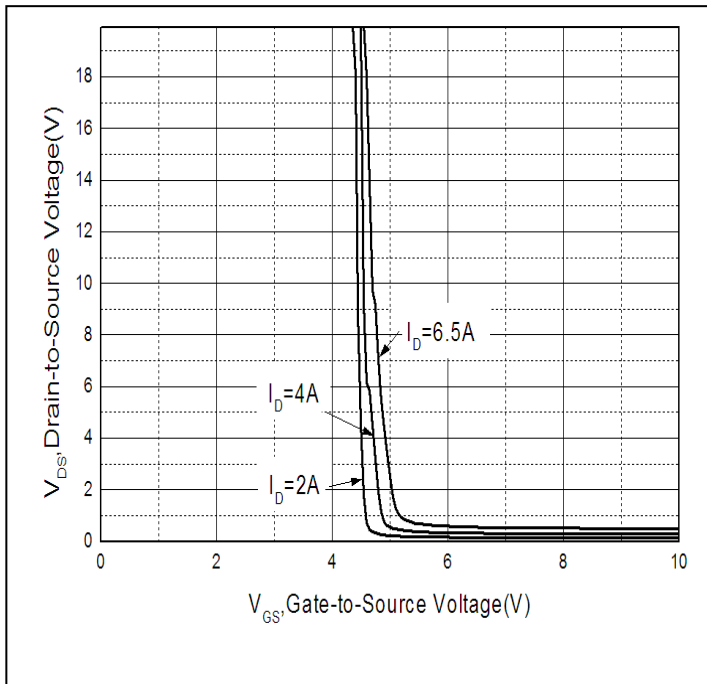
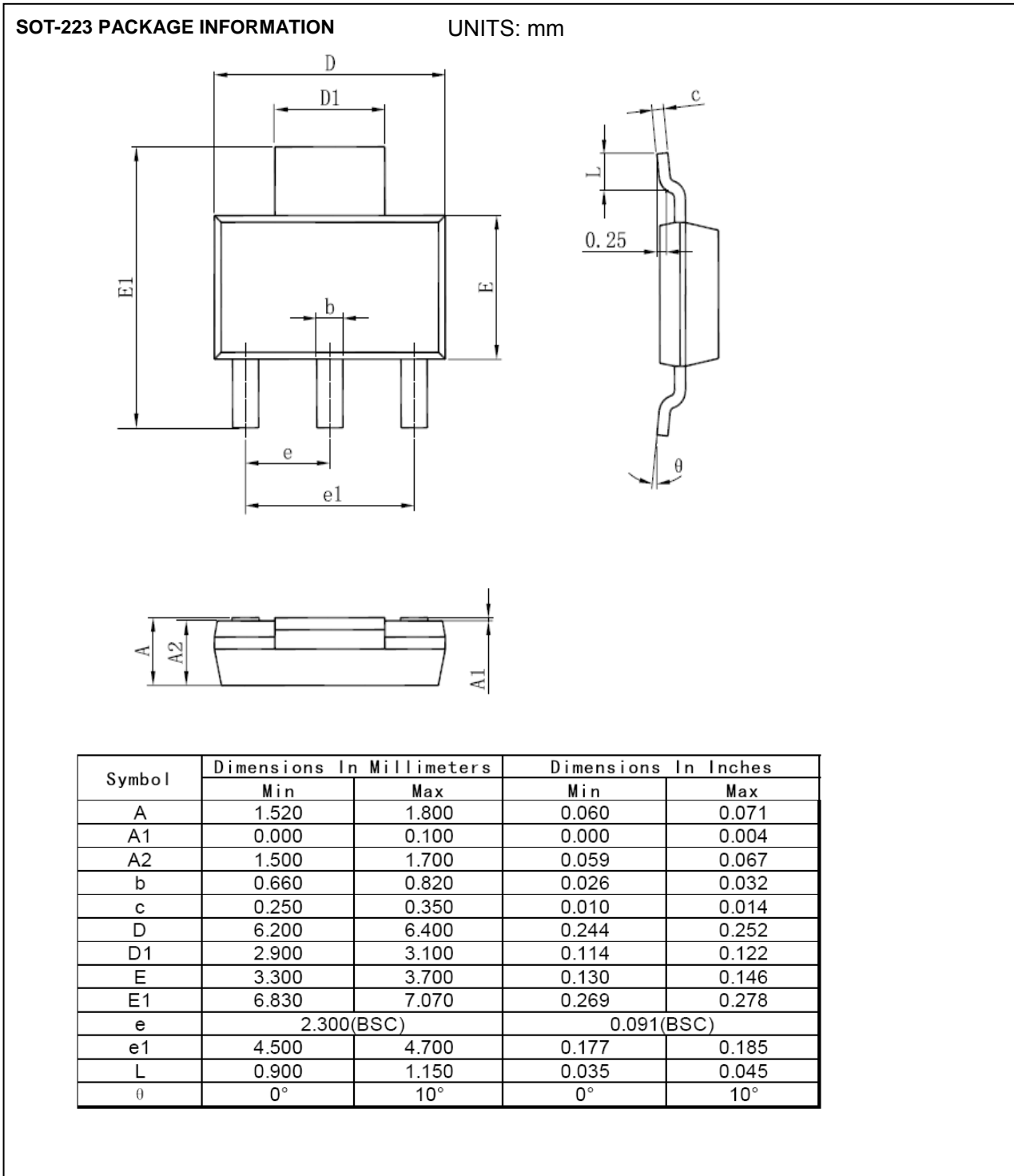


Figure 7: Drain-to-Source Voltage Vs. Gate-to-Source Voltage

**Mechanical Data:**


**Ordering and Marking Information**
**Device Marking: SSF0115**

**Package (Available)**  
**SOT-223**  
**Operating Temperature Range**  
**C : -55 to 175 °C**

**Devices per Unit**

Package Type	Units/Tape	Tapes/Inner Box	Units/Inner Box	Inner Boxes/Carton Box	Units/Carton Box
SOT-223	2500	1	2500	8	20000

**Reliability Test Program**

Test Item	Conditions	Duration	Sample Size
High Temperature Reverse Bias(HTRB)	T <sub>j</sub> =125°C to 175°C @ 80% of Max V <sub>DSS</sub> /V <sub>CES</sub> /VR	168 hours 500 hours 1000 hours	3 lots x 77 devices
High Temperature Gate Bias(HTGB)	T <sub>j</sub> =150°C or 175°C @ 100% of Max V <sub>GSS</sub>	168 hours 500 hours 1000 hours	3 lots x 77 devices

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